

TOSHIBA TRANSISTOR SILICON PNP TRIPLE DIFFUSED TYPE

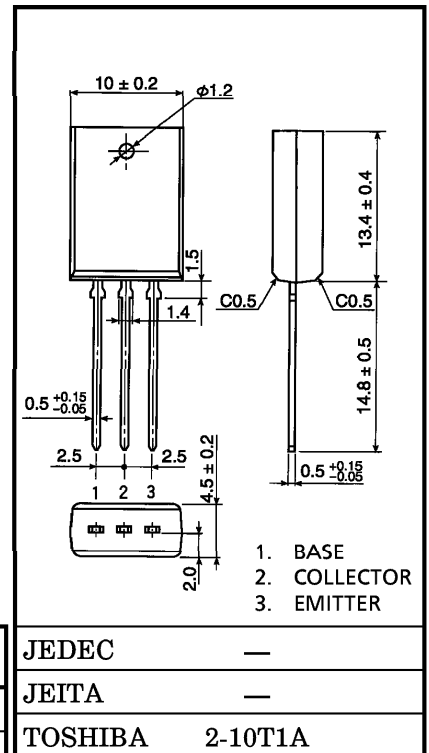
2SB1641

HIGH POWER SWITCHING APPLICATIONS

HAMMER DRIVE, PULSE MOTOR DRIVE APPLICATIONS

- High DC Current Gain
: $h_{FE} = 1500$ (Min.) ($V_{CE} = -3V$, $I_C = -2.5A$)
- Low Saturation Voltage
: $V_{CE(sat)} = -1.5V$ (Max.) ($I_C = -2.5A$)
- Complementary to 2SD2526

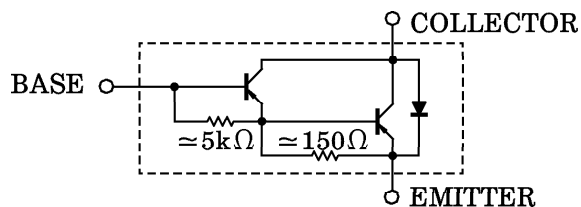
Unit in mm



MAXIMUM RATINGS ($T_a = 25^\circ C$)

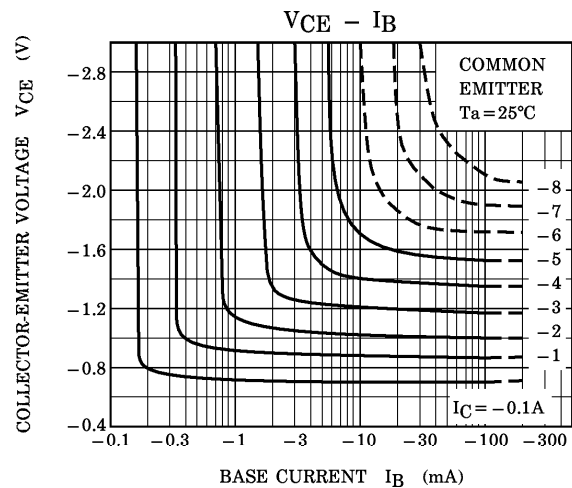
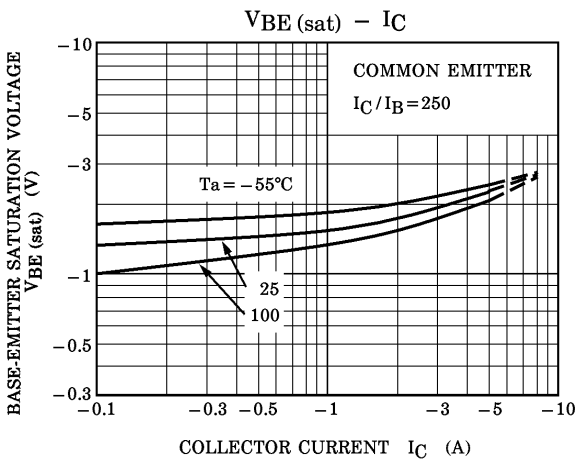
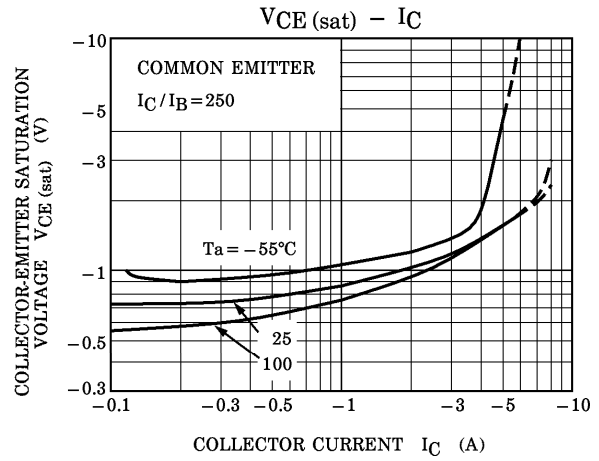
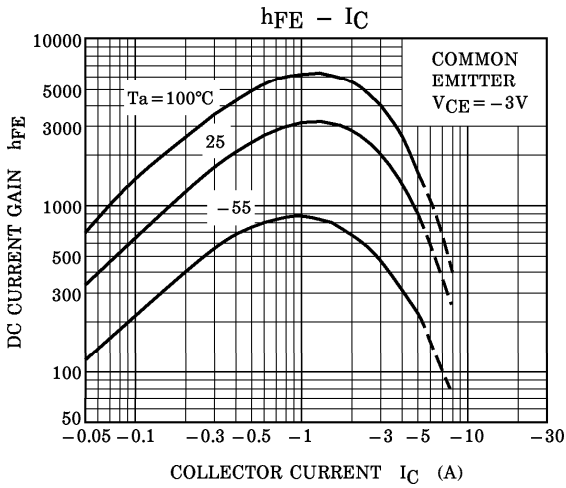
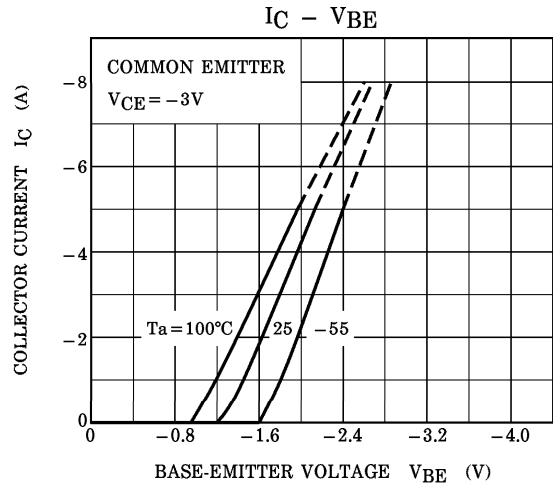
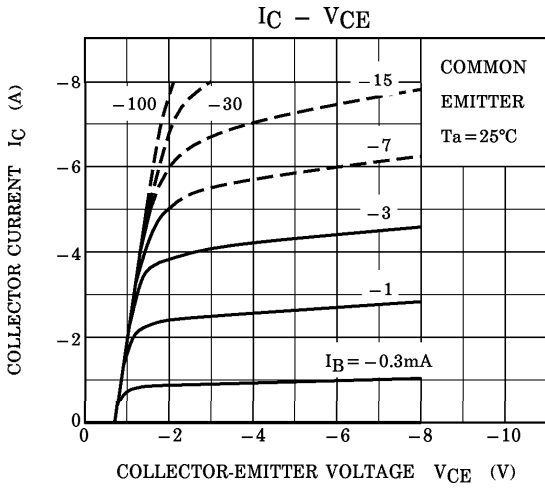
CHARACTERISTIC	SYMBOL	RATING	UNIT	
Collector-Base Voltage	V_{CBO}	-100	V	
Collector-Emitter Voltage	V_{CEO}	-100	V	
Emitter-Base Voltage	V_{EBO}	-7	V	
Collector Current	DC Pulse	I_C	-5	A
			-8	
Base Current	I_B	-0.5	A	
Collector Power Dissipation	P_C	1.8	W	
Junction Temperature	T_j	150	$^\circ C$	
Storage Temperature Range	T_{stg}	-55~150	$^\circ C$	

EQUIVALENT CIRCUIT



ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current		I_{CBO}	$V_{CB} = -100V, I_E = 0$	—	—	-100	μA
Emitter Cut-off Current		I_{EBO}	$V_{EB} = -6V, I_C = 0$	—	—	-2.5	mA
Collector-Emitter Breakdown Voltage		$V_{(BR) CEO}$	$I_C = -30mA, I_B = 0$	-100	—	—	V
DC Current Gain		$h_{FE (1)}$	$V_{CE} = -3V, I_C = -2.5A$	1500	—	15000	
		$h_{FE (2)}$	$V_{CE} = -3V, I_C = -7A$	500	—	—	
Collector-Emitter Saturation Voltage		$V_{CE (sat) (1)}$	$I_C = -2.5A, I_B = -5mA$	—	-1.1	-1.5	V
		$V_{CE (sat) (2)}$	$I_C = -5A, I_B = -20mA$	—	-1.6	-3.0	
Base-Emitter Saturation Voltage		$V_{BE (sat)}$	$I_C = -2.5A, I_B = -5mA$	—	-1.8	-2.5	V
Switching Time	Turn-on Time	t_{on}	<p> $-I_{B1} = I_{B2} = 5mA$ DUTY CYCLE $\leq 1\%$ $V_{CC} = -25V$ </p>	—	0.8	—	μs
	Storage Time	t_{stg}		—	2.5	—	
	Fall Time	t_f		—	2.0	—	



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